

#### **Key Features**

- 3W Output at 10% THD with a 3Ω Load and 5V Power Supply
- 2.5W Output at 10% THD with a 4Ω Load and 5V Power Supply
- Filterless, Low Quiescent Current and Low EMI
- Low THD+N
- Superior Low Noise
- Short Circuit Protection
- Thermal Shutdown
- Few External Components to Save the Space and Cost
- Pb-Free Package

## **Applications**

- Portable Speakers
- LCD Monitors / TV
- Notebook Computers
- Portable DVD Players, Game Machines

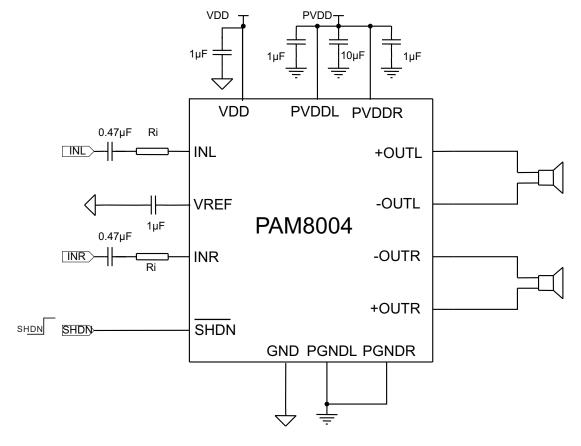
#### **General Description**

The PAM8004 is a 3W, class-D audio amplifier. It offers low THD+N, allowing it to achieve high-quality sound reproduction. The new filterless architecture allows the device to drive the speaker directly, requiring no low-pass output filters, thus to save the system cost and PCB area.

With the same numbers of external components, the efficiency of the PAM8004 is much better than that of class-AB cousins. It can extend the battery life, ideal for portable applications.

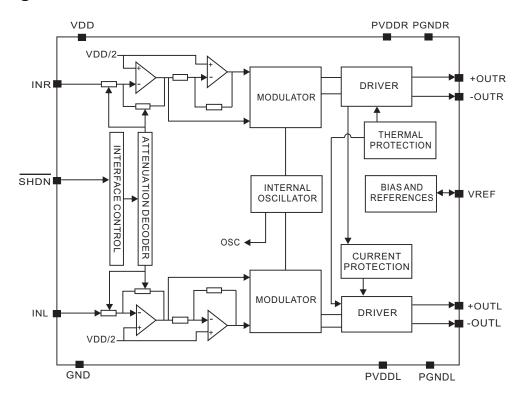
The PAM8004 is available in SOP-16L package.

## **Typical Application**

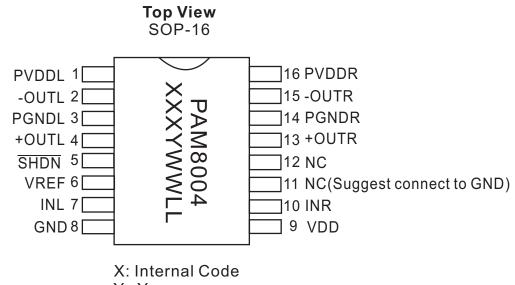




#### **Block Diagram**



## Pin Configuration & Marking Information



Y: Year WW: Week

LL: Internal Code



## **Pin Descriptions**

Pin Number	Pin Name	Description
1	PVDDL	Left Channel Power Supply
2	-OUTL	Left Channel Negative Output
3	PGNDL	Left Channel Power GND
4	+OUTL	Left Channel Positive Output
5	SHDN	Shutdown Control Input(active low)
6	VREF	Internal analog reference, connect a bypass capacitor from VREF to GND
7	INL	Left Channel Input
8	GND	Analog Ground
9	VDD	Analog Power Supply
10	INR	Right Channel Input
11	NC	No Connected (Suggest connect to GND)
12	NC	No Connected
13	+OUTR	Right Channel Positive Output
14	PGNDR	Right Channel Power GND
15	-OUTR	Right Channel Negative Output
16	PVDDR	Right Channel Power Supply

## **Absolute Maximum Ratings**

These are stress ratings only and functional operation is not implied. Exposure to absolute maximum ratings for prolonged time periods may affect device reliability. All voltages are with respect to ground.

Supply Voltage6.0V	Storage Temperature65°C to 150°C
Input Voltage0.3V to V <sub>DD</sub> +0.3V	Soldering Temperature300°C, 5sec
Maximum Junction Temperature150°C	

## **Recommended Operating Conditions**

Supply voltage Range2.5V to 5.5V	Operation Temperature Range40°C to 85°C
	Junction Temperature Range40°C to 125°C

#### Thermal Information

Parameter	Symbol	Package	Maximum	Unit
Thermal Resistance (Junction to Ambient)	$\theta_{JA}$	SOP-16L	110	°CW
Thermal Resistance (Junction to Case)	$\theta_{JC}$	SOP-16L	23	°CW
Internal PowerDissipation @ TA=25°C	Pb	SOP-16L	900	mW



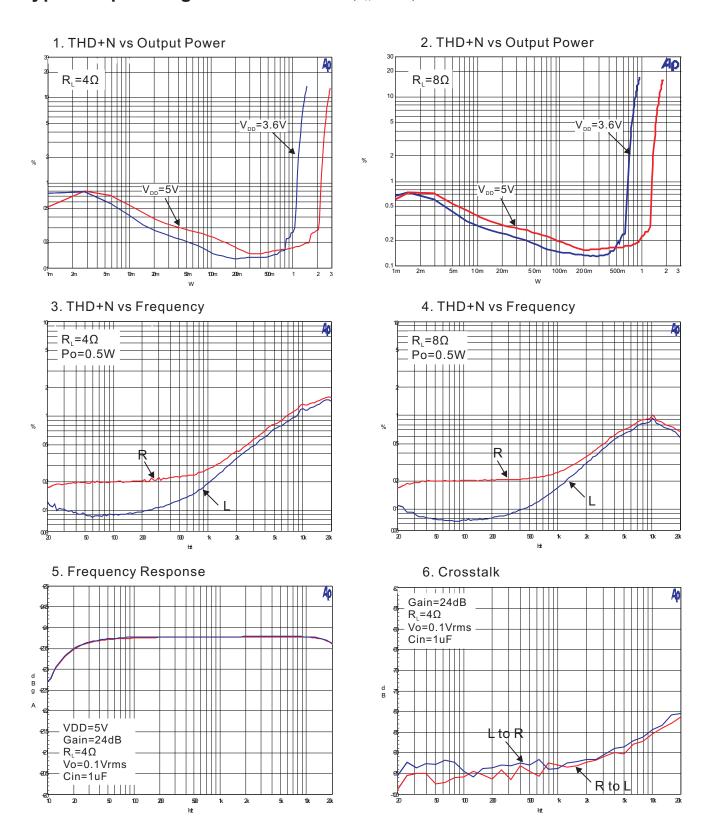
## **Electrical Characteristic**

 $V_{DD}$ =5V, Gain=24dB, R<sub>L</sub>=8 $\Omega$ , T<sub>A</sub>=25°C, unless otherwise noted.

Symbol	Parameter	Test Conditions		MIN	TYP	MAX	UNIT
V <sub>IN</sub>	Supply Power			2.5		5.5	V
		THD+N=10%,f=1kHz, $R_L$ =4 $\Omega$	V <sub>DD</sub> =5.0V		2.5		W
Po	Output Down	THD+N=1%,f=1kHz, $R_L$ =4 $\Omega$	V <sub>DD</sub> =5.0V		2.2		W
PO	Output Power	THD+N=10%,f=1kHz, $R_L$ =8 $\Omega$	V <sub>DD</sub> =5.0V		1.65		W
		THD+N=1%,f=1kHz, R <sub>L</sub> =8 Ω	V <sub>DD</sub> =5.0V		1.3		W
		V <sub>DD</sub> =5.0V,Po=0.5W,R <sub>L</sub> =8 Ω	f=1kHz		0.16		%
THD+N	Total Harmonic Distortion Plus	$V_{DD}$ =3.6 $V$ ,Po=0.5 $W$ ,RL=8 $\Omega$	I-TKHZ		0.12		
IUD+N	Noise	$V_{DD}$ =5.0 $V$ , $Po$ =1 $W$ , $R_L$ =4 $\Omega$	f=1kHz		0.17		
		V <sub>DD</sub> =3.6V,Po=1W,R <sub>L</sub> =4 Ω	I-TKHZ		0.26		
PSRR	Power Supply Ripple Rejection				-70		dB
Cs	Crosstalk	$C_{IN}=0.47 \mu F, Gv=6 dB$ $V_{DD}=5V, Po=0.5W, R_L=8\Omega, Gv=20 dB$	F=1kHz		-93		dB
SNR	Signal-to-noise ratio	V <sub>DD</sub> =5V, F0=0.3VV, RL=6k2, GV=20dB	f=1kHz		86		dВ
ONIX	Olgitario-noise ratio	V <sub>DD</sub> =5V, Inputs ac-grounded with	A-weighting		33		QD.
Vn	Output noise	C <sub>IN</sub> =0.47μF,Gv=6dB	- 3 7 3		50		μV
		R <sub>L</sub> =8Ω, THD=10%	No 71 Weighting		87		
η	Efficiency	R <sub>L</sub> =4Ω, THD=10%	f=1kHz		79		%
		V <sub>DD</sub> =5.0V			4.5	7	
l <sub>o</sub>	Quiescent Current	V <sub>DD</sub> =3.6V	No load		4	6.5	mA
		V <sub>DD</sub> =3.0V			3.7	5.5	
I <sub>SD</sub>	Shutdown Current	V <sub>DD</sub> =2.5V to 5.5V				1	μA
	Static Drain-to-source On-state		PMOS	0.41		†	
Rdson	Resistor	I <sub>DS</sub> =500mA,Vgs=5V	NMOS		0.27		mΩ
fsw	Switching Frequency	V <sub>DD</sub> =3V to 5V			210		kHz
Vos	Output Offset Voltage	Vin=0V, V <sub>DD</sub> =5V			10		mV
ViH	Enable Input High Voltage	V <sub>DD</sub> =5.0V		1.5			
V <sub>IL</sub>	Enable Input Low Voltage	V <sub>DD</sub> =5.0V	V <sub>DD</sub> =5.0V			0.4	· V
ОТР	Over Temperature Protection				150		
ОТН	Over Temperature Hysterisis	No Load, Junction Temperature	V <sub>DD</sub> =5V		30		°C

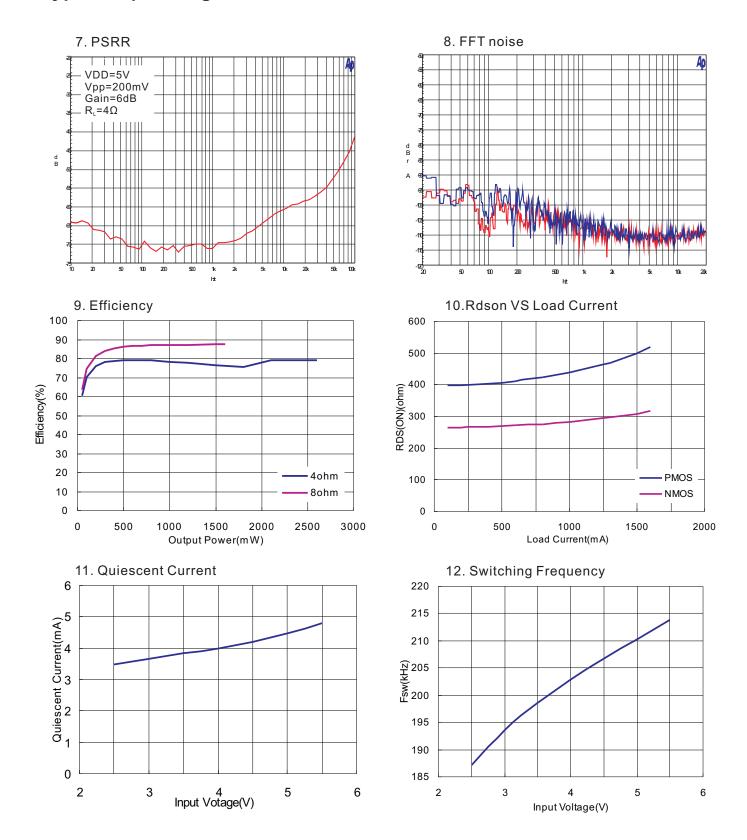


## **Typical Operating Characteristics** (T<sub>A</sub>=25°C)





## **Typical Operating Characteristics** (continued)



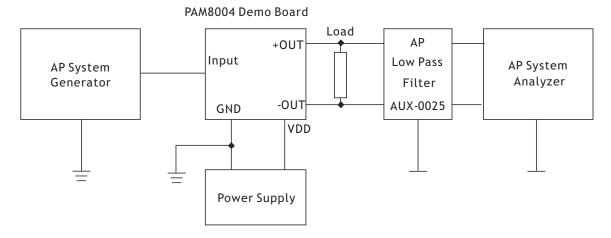


### **Application Notes**

- 1. When the PAM8004 works with LC filters, it should be connected with the speaker before it's powered on, otherwise it will be damaged easily.
- 2. When the PAM8004 works without LC filters, it's better to add a ferrite chip bead at the outgoing line of speaker for suppressing the possible electromagnetic interference.
- 3. The recommended operating voltage is 5.5V. When the PAM8004 is powered with 4 battery cells, it should be noted that the voltage of 4 new dry or alkaline batteries is over 6.0V, higher than its operation voltage, which will

- probably damage the device. Therefore, it's recommended to use either 4 Ni-MH (Nickel Metal Hydride) rechargeable batteries or 3 dry or alkaline batteries.
- 4. One should not make the input signal too large. Large signal can cause the clipping of output signal when increasing the volume. This will damage the device because of big gain of the PAM8004.
- 5. When testing the PAM8004 without LC filters by using resistor instead of speaker as the output load, the test results, e.g. THD or efficiency, will be worse than those of using speaker as load.

### **Test Setup for Performance Testing**



#### **Notes**

- 1. The AP AUX-0025 low pass filter is necessary for class-D amplifier measurement with AP analyzer.
- 2. Two 22µH inductors are used in series with load resistor to emulate the small speaker for efficiency measurement.



## **Application Information**

#### **Maximum Gain**

As shown in block diagram (page 2), the PAM8403 has two internal amplifier stages. The first stage's gain is externally configurable, while the second stage's is internally fixed. The closed-loop gain of the first stage is set by selecting the ratio of  $R_{\rm f}$  to  $R_{\rm i}$  while the second stage's gain is fixed at 2x. The output of amplifier 1 serves as the input to amplifier 2, thus the two amplifiers produce signals identical in magnitude, but different in phase by 180°. Consequently, the differential gain for the IC is

$$A_{VD} = 20 \log [2 (R_{I}/R_{i})]$$

The PAM8403 sets maximum  $R_i$ =142k $\Omega$ , minimum  $R_i$ =18k $\Omega$ , so the maximum closed-gain is 24dB.

#### Power supply decoupling

The PAM8004 is a high performance CMOS audio amplifier that requires adequate power supply decoupling to ensure the output THD and PSRR as low as possible. Power supply decoupling affects low frequency response. Optimum decoupling is achieved by using two capacitors of different types targeting to different types of noise on the power supply leads. For higher frequency transients, spikes, or digital hash on the line, a good low equivalent-seriesresistance (ESR) ceramic capacitor, typically 1.0µF, works best, placing it as close as possible to the device  $V_{\scriptscriptstyle DD}$  terminal. For filtering lowerfrequency noise signals, a large capacitor of 20µF (ceramic) or greater is recommended, placing it near the audio power amplifier.

#### Input Capacitor (C<sub>i</sub>)

Large input capacitors are both expensive and space hungry for portable designs. Clearly, a certain sized capacitor is needed to couple in low frequencies without severe attenuation. But in many cases the speakers used in portable systems, whether internal or external, have little ability to reproduce signals below 100Hz to 150Hz. Thus, using a large input capacitor may not increase actual system performance. In this case, input capacitor (C<sub>i</sub>) and input resistance (R<sub>i</sub>) of the amplifier form a high-pass filter with the corner frequency determined by equation below.

$$f_C = \frac{1}{2\pi R_i C_i}$$

In addition to system cost and size, click and pop performance is affected by the size of the input coupling capacitor,  $C_i$ . A larger input coupling capacitor requires more charge to reach its quiescent DC voltage (nominally  $1/2~V_{DD}$ ). This charge comes from the internal circuit via the feedback and is apt to create pops upon device enable. Thus, by minimizing the capacitor size based on necessary low frequency response, turn-on pops can be minimized.

#### Analog Reference Bypass Capacitor (C<sub>BYP</sub>)

The Analog Reference Bypass Capacitor ( $C_{\text{BYP}}$ ) is the most critical capacitor and serves several important functions. DuAring start-up or recovery from shutdown mode,  $C_{\text{BYP}}$  determines the rate at which the amplifier starts up. The second function is to reduce noise caused by the power supply coupling into the output drive signal. This noise is from the internal analog reference to the amplifier, which appears as degraded PSRR and THD+N.

A ceramic bypass capacitor ( $C_{\text{BYP}}$ ) with values of 0.1µF to 1.0µF is recommended for the best THD and noise performance. Increasing the bypass capacitor reduces clicking and popping noise from power on/off and entering and leaving shutdown.

#### Under Voltage Lock-out (UVLO)

The PAM8004 incorporates circuitry designed to detect low supply voltage. When the supply voltage drops to 2.0V or below, the PAM8004 outputs are disabled, and the device comes out of this state and starts to normal function when  $V_{\text{DD}} \geqslant 2.2\text{V}$ .

#### **Short Circuit Protection (SCP)**

The PAM8004has short circuit protection circuitry on the outputs to prevent damage to the device when output-to-output or output-to-GND short occurs. When a short circuit is detected on the outputs, the outputs are disabled immediately. If the short was removed, the device activates again.



#### **Application Information**

#### **Over Temperature Protection**

Thermal protection on the PAM8004 prevents the device from damage when the internal die temperature exceeds 140°C. There is a 15 degree tolerance on this trip point from device to device. Once the die temperature exceeds the thermal set point, the device outputs are disabled. This is not a latched fault. The thermal fault is cleared once the temperature of the die is reduced by 30°C. This large hysteresis will prevent motor boating sound well and the device begins normal operation at this point without external system intervention.

# How to Reduce EMI (Electro Magnetic Interference)

A simple solution is to put an additional capacitor  $1000\mu F$  at power supply terminal for power line coupling if the traces from amplifier to speakers are short (<20cm).

Most applications require a ferrite bead filter as shown in Figure 2. The ferrite filter reduces EMI of around 1 MHz and higher. When selecting a ferrite bead, choose one with high impedance at high frequencies, and low impedance at low frequencies.

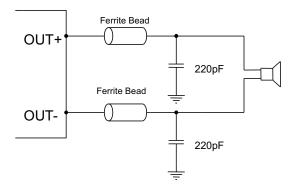


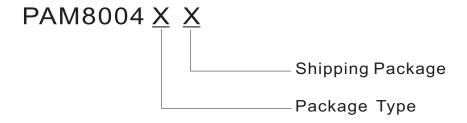
Figure 2: Ferrite Bead Filter to reduce EMI



# **PAM8004**

# Filterless 3W Class-D Stereo Audio Amplifier

## **Ordering Information**

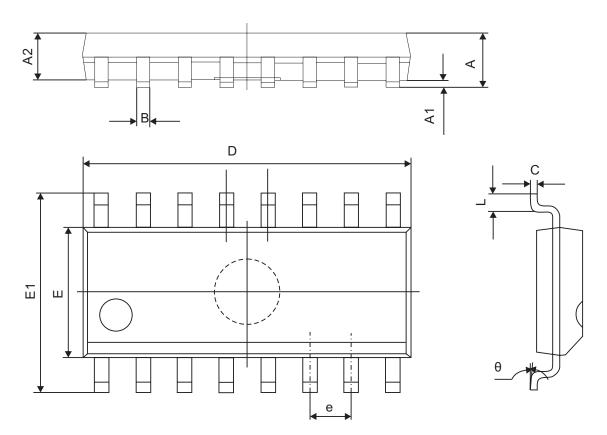


Part Number	Marking	Package Type	MOQ/Shipping Package
PAM8004DR	PAM8004 XATYWWLL	SOP-16L	2,500 Units/Tape&Reel



## **Outline Dimension**

## **SOP-16**



Symbol	Dimensions Millimeters		
	Min	Max	
А	1.350	1.750	
A1	0.100	0.250	
A2	1.350	1.550	
В	0.330	0.510	
С	0.190	0.250	
D	9.800	10.000	
E	3.800	4.000	
E1	5.800	6.300	
е	1.270(TYP)		
L	0.400	1.270	
θ	0°	8°	